















Official M&M 2014 Program Guide



Revolutionary SEM Control Debuts at M&M 2014



EM Wizard Changes the Game

SEM operation, as you currently know it, is about to change. Groundbreaking computer-assisted technology from Hitachi, referred to as EM Wizard, offers a new level of SEM operation and control. Expert or novice, the result is now the same: Highest quality nano-scale images at your fingertips!

Schedule a demo of the all new Hitachi SU5000 FE-SEM and experience EM Wizard at:

Booth #218

Many More Exiciting New Products from Hitachi



IM4000 Plus Cryo



- **Ion Milling Systems**—Enhanced gun design for faster milling without compromising sample integrity. New cryo system available!
- Tabletop SEM—World's most popular tabletop SEM, the TM Series, now with a NEW Ultra Variable Detector!
- **FIB-SEM Systems**—New, innovative configurations for advanced TEM sample preparation and high-resolution 3-D analysis.
- Atomic Force Microscope
 —Robust, bench-top system with self-aligning cantilever and point-and-click auto tuning.

Inspire Innovation through Collaboration

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Microscopy & Microanalysis

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